PD - 9.1496A

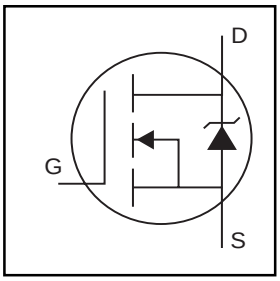
International
IOR Rectifier

PRELIMINARY

IRLI520N

HEXFET® Power MOSFET

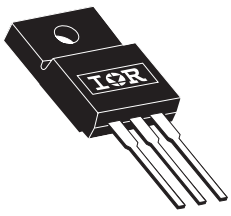
- Logic-Level Gate Drive
- Advanced Process Technology
- Isolated Package
- High Voltage Isolation = 2.5KVRMS ⑤
- Sink to Lead Creepage Dist. = 4.8mm
- Fully Avalanche Rated



V_{DSS} = 100V

$R_{DS(on)}$ = 0.18Ω

I_D =8.1A



TO-220 FULLPAK

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.

Absolute Maximum Ratings

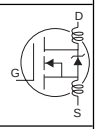
	Parameter	Max.	Units
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ 10V	8.1	A
I_D @ T_C = 100°C	Continuous Drain Current, V_{GS} @ 10V	5.7	
I_{DM}	Pulsed Drain Current ①⑥	35	
P_D @T_C = 25°C	Power Dissipation	30	W
	Linear Derating Factor	0.20	W/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
E_{AS}	Single Pulse Avalanche Energy②⑥	85	mJ
I_{AR}	Avalanche Current①⑥	6.0	A
E_{AR}	Repetitive Avalanche Energy①	3.0	mJ
dv/dt	Peak Diode Recovery dv/dt ③⑥	5.0	V/ns
T_J	Operating Junction and	-55 to + 175	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	5.0	°C/W
$R_{\theta JA}$	Junction-to-Ambient	—	65	

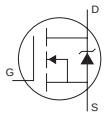
Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100	—	—	V	V_{GS} = 0V, I_D = 250µA
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.11	—	V/°C	Reference to 25°C, I_D = 1mA⑥
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.18	Ω	V_{GS} = 10V, I_D = 6.0A ④
		—	—	0.22		V_{GS} = 5.0V, I_D = 6.0A ④
		—	—	0.26		V_{GS} = 4.0V, I_D = 5.0A ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0	—	2.0	V	V_{DS} = V_{GS}, I_D = 250µA
g_{fs}	Forward Transconductance	3.1	—	—	S	V_{DS} = 25V, I_D = 6.0A⑥
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	µA	V_{DS} = 100V, V_{GS} = 0V
		—	—	250		V_{DS} = 80V, V_{GS} = 0V, T_J = 150°C
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	V_{GS} = 16V
	Gate-to-Source Reverse Leakage	—	—	-100		V_{GS} = -16V
Q_g	Total Gate Charge	—	—	20	nC	I_D = 6.0A
Q_{gs}	Gate-to-Source Charge	—	—	4.6		V_{DS} = 80V
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	10		V_{GS} = 5.0V, See Fig. 6 and 13 ④⑥
$t_{d(on)}$	Turn-On Delay Time	—	40	—	ns	V_{DD} = 50V
t_r	Rise Time	—	35	—		I_D = 6.0A
$t_{d(off)}$	Turn-Off Delay Time	—	23	—		R_G = 11Ω, V_{GS} = 5.0V
t_f	Fall Time		22			R_D = 8.2Ω, See Fig. 10 ④⑥
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	440	—	pF	V_{GS} = 0V
C_{oss}	Output Capacitance	—	97	—		V_{DS} = 25V
C_{rss}	Reverse Transfer Capacitance	—	50	—		f = 1.0MHz, See Fig. 5⑥
C	Drain to Sink Capacitance	—	12	—		f = 1.0MHz



Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	8.1	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①⑥	—	—	35		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	T_J = 25°C, I_S = 6.0A, V_{GS} = 0V ④
t_{rr}	Reverse Recovery Time	—	110	160	ns	T_J = 25°C, I_F = 6.0A
Q_{rr}	Reverse Recovery Charge	—	410	620	nC	di/dt = 100A/µs ④⑥
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				



Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② Starting T_J = 25°C, L = 4.7mH R_G = 25Ω, I_{AS} = 6.0A. (See Figure 12)

③ I_{SD} ≤ 6.0A, di/dt ≤ 340A/µs, V_{DD} ≤ $V_{(BR)DSS}$, T_J ≤ 175°C

④ Pulse width ≤ 300µs; duty cycle ≤ 2%.

⑤ t=60s, f=60Hz

⑥ Uses IRL520N data and test conditions